

Search Notes

Application/Control No.

10/797,824

Examiner

Charles R. Kasenge

Applicant(s)/Patent under
Reexamination

CHAO ET AL.

Art Unit

2125

SEARCHED

Class	Subclass	Date	Examiner
700	99	7/7/2005	CK
	100		
	101		
	112		
	113		
	121		
438	8		
	14		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search; search terms: wafer, layer\$3, lot, replac\$3	7/7/2005	CK